Application/Control No. Applicant(s)/Patent Under Reexamination 10/038,501 SUNDAHL ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2629 Kevin M. Nguyen **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,847,415 01-2005 Yoshimura et al. 349/58 Α US-В US-С US-D US-Ε US-F US-G USн US-١ US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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